

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/815,448	AWN ET AL.
	Examiner	Art Unit
	Thao X. Le	2814

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see print out	6/14/2005	TL
See print out	10/11/2005	TL
see printout	2/19/2006	TL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner